MOSFET – Power, Single, N-Channel, μCool, UDFN6, 2.0x2.0x0.55 mm 30 V, 6.1 A

Features

- UDFN Package with Exposed Drain Pads for Excellent Thermal Conduction
- Low Profile UDFN 2.0 x 2.0 x 0.55 mm for Board Space Saving
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- Battery Switch
- Power Load Switch
- DC-DC Converters

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Parameter		Symbol	Value	Unit	
Drain-to-Source Voltage		V_{DSS}	30	V	
Gate-to-Source Voltage		V_{GS}	±20	V	
Continuous Drain	Steady	T _A = 25°C	I _D	6.1	Α
Current (Note 1) Continuous Drain	State	T _A = 85°C		4.4	
Current (Note 1)	t ≤ 5 s	T _A = 25°C		9.3	
Power Dissipa- tion (Note 1)	Steady State	T _A = 25°C	P _D	1.65	W
	t ≤ 5 s	T _A = 25°C		3.8	
Continuous Drain	Steady State	T _A = 25°C	I _D	3.8	Α
Current (Note 2)	State	T _A = 85°C		2.8	
Power Dissipation (Note 2) T _A = 25°C		P _D	0.65	W	
Pulsed Drain Current tp = 10 μs		I _{DM}	19	Α	
MOSFET Operating Junction and Storage Temperature		T _J , T _{STG}	-55 to 150	°C	
Source Current (Body Diode) (Note 1)		I _S	1.65	Α	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		TL	260	°C	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

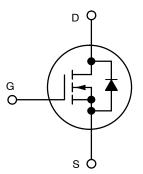
- Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).
- Surface-mounted on FR4 board using the minimum recommended pad size of 30 mm², 2 oz. Cu.



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MOSFET				
V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX		
30 V	36 mΩ @ 4.5 V	6.1 A		
	28.5 mΩ @ 10 V	5.5 A		



N-CHANNEL MOSFET

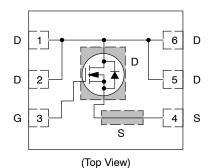
S MARKING DIAGRAM UDFN6 (µCOOL™) CASE 517BG MARKING DIAGRAM AD M CASE 517BG

AD = Specific Device Code M = Date Code

= Pb-Free Package

(*Note: Microdot may be in either location)

PIN CONNECTIONS



ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 3 of this data sheet.

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient – Steady State (Note 3)	$R_{\theta JA}$	75.7	
Junction-to-Ambient – t ≤ 5 s (Note 3)	$R_{\theta JA}$	32.9	°C/W
Junction-to-Ambient – Steady State min Pad (Note 4)	$R_{\theta JA}$	191.4	

- Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).
 Surface-mounted on FR4 board using the minimum recommended pad size of 30 mm², 2 oz. Cu.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

ParameterSymbolTest ConditionMinTypOFF CHARACTERISTICSDrain-to-Source Breakdown Voltage Temperature Coefficient $V_{(BR)DSS}$ $V_{GS} = 0 \text{ V}, I_D = 250 \text{ μA}$ 30Drain-to-Source Breakdown Voltage Temperature Coefficient $V_{(BR)DSS}/T_J$ $I_D = 250 \text{ μA}, \text{ ref to } 25^{\circ}\text{C}$ +16Zero Gate Voltage Drain Current I_{DSS} $V_{GS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$ $V_{JS} = 24 \text{ V}$ $V_{JS} = 24 \text{ V}$ Gate-to-Source Leakage Current I_{GSS} $V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$ $V_{JS} = \pm 20 \text{ V}$ ON CHARACTERISTICS (Note 5)Gate Threshold Voltage $V_{GS}(TH)$ $V_{GS} = V_{DS}, I_D = 250 \text{ μA}$ 1.21.8Negative Threshold Temp. Coefficient $V_{GS}(TH)/T_J$ 4.4Drain-to-Source On Resistance $V_{GS}(TH)/T_J$ 4.4Forward Transconductance $V_{SS}(TH)/T_S$ $V_{SS}(TH)/T_S = 0.0 \text{ A}$ 16	1.0 10 2.2 28.5 36	V mV/°C μA μA V mV/°C mΩ mΩ
Drain-to-Source Breakdown Voltage $V_{(BR)DSS}$ $V_{GS} = 0 \text{ V}, I_D = 250 \text{ μA}$ 30Drain-to-Source Breakdown Voltage Temperature Coefficient $V_{(BR)DSS}/T_J$ $I_D = 250 \text{ μA}, \text{ ref to } 25^{\circ}\text{C}$ $+16$ Zero Gate Voltage Drain Current I_{DSS} $V_{GS} = 0 \text{ V}, V_{DS} = 24 \text{ V}$ $T_J = 25^{\circ}\text{C}$ Gate-to-Source Leakage Current I_{GSS} $V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$ ON CHARACTERISTICS (Note 5)Gate Threshold Voltage $V_{GS}(TH)$ $V_{GS} = V_{DS}, I_D = 250 \text{ μA}$ 1.21.8Negative Threshold Temp. Coefficient $V_{GS}(TH)/T_J$ 4.4Drain-to-Source On Resistance $R_{DS}(on)$ $V_{GS} = 10 \text{ V}, I_D = 6.1 \text{ A}$ 19 $V_{GS} = 4.5 \text{ V}, I_D = 5.5 \text{ A}$ 27	2.2	mV/°C μA μA V mV/°C
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	2.2	mV/°C μA μA V mV/°C
Temperature Coefficient	2.2	μA μA V mV/°C
$V_{DS} = 24 \text{ V}$ Gate-to-Source Leakage Current I_{GSS} $V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$ ON CHARACTERISTICS (Note 5) Gate Threshold Voltage $V_{GS(TH)}$ $V_{GS} = V_{DS}, I_D = 250 \mu\text{A}$ 1.2 1.8 Negative Threshold Temp. Coefficient $V_{GS(TH)}/T_J$ 4.4 Drain-to-Source On Resistance $R_{DS(on)}$ $V_{GS} = 10 \text{ V}, I_D = 6.1 \text{ A}$ 19 $V_{GS} = 4.5 \text{ V}, I_D = 5.5 \text{ A}$ 27	2.2	μA V mV/°C
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	2.2	V mV/°C
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	28.5	mV/°C
Negative Threshold Temp. Coefficient $V_{GS(TH)}/T_J$ 4.4 Drain-to-Source On Resistance $R_{DS(on)}$ $V_{GS} = 10 \text{ V}, I_D = 6.1 \text{ A}$ 19 $V_{GS} = 4.5 \text{ V}, I_D = 5.5 \text{ A}$ 27	28.5	mV/°C
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	_	· ·
$V_{GS} = 4.5 \text{ V}, I_D = 5.5 \text{ A}$ 27	_	mΩ
	36	_
Forward Transcenductores a V 15VI 60A		
Forward Transconductance g_{FS} $V_{DS} = 1.5 \text{ V}, I_D = 6.0 \text{ A}$ 16		S
CHARGES, CAPACITANCES & GATE RESISTANCE		
Input Capacitance C _{ISS} 476		pF
Output Capacitance C_{OSS} $V_{GS} = 0 \text{ V, f} = 1 \text{ MHz,} \\ V_{DS} = 15 \text{ V}$ 197		
Reverse Transfer Capacitance C _{RSS} 100		
Total Gate Charge Q _{G(TOT)} 4.8		nC
Threshold Gate Charge $Q_{G(TH)}$ $V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V};$ 0.4 Gate-to-Source Charge Q_{GS}		
Gate-to-Source Charge Q_{GS} $I_D = 5.5 \text{ A}$ 1.54		
Gate-to-Drain Charge Q _{GD} 2.15		1
$Q_{G(TOT)}$ $V_{GS} = 10 \text{ V}, V_{DS} = 15 \text{ V};$ $I_{D} = 5.5 \text{ A}$ 8.7		nC
SWITCHING CHARACTERISTICS, VGS = 4.5 V (Note 6)		-
Turn-On Delay Time t _{d(ON)} 8.7		ns
Rise Time t_r $V_{GS} = 4.5 \text{ V}, V_{DD} = 15 \text{ V},$ 14.4	1	
Turn-Off Delay Time $t_{d(OFF)}$ $I_D = 5.5 \text{ A}, R_G = 3 \Omega$ 9.1	1	
Fall Time t _f 3.3	1	1
SWITCHING CHARACTERISTICS, VGS = 10 V (Note 6)		
Turn-On Delay Time t _{d(ON)} 4.1	\top	ns
Rise Time t_r $V_{GS} = 10 \text{ V}, V_{DD} = 15 \text{ V},$ 12.2	+	1
Turn-Off Delay Time $t_{d(OFF)}$ $I_D = 6.1 \text{ A}, R_G = 3 \Omega$ 11.6	1	1
Fall Time t _f 2.2	1	1
DRAIN-SOURCE DIODE CHARACTERISTICS		
Forward Diode Voltage V_{SD} $V_{GS} = 0 \text{ V},$ $T_J = 25^{\circ}\text{C}$ 0.80	1.0	V
$I_{S} = 1.65 \text{ A}$ $I_{J} = 125^{\circ}\text{C}$ 0.67	+	1

- 5. Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
 6. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition	Min	Тур	Max	Units
DRAIN-SOURCE DIODE CHARACTERISTICS						
Reverse Recovery Time	t _{RR}			14.6		ns
Charge Time	t _a	V_{GS} = 0 V, dIs/dt = 100 A/ μ s, I _S = 3.3 A		6.8		
Discharge Time	t _b			7.8		
Reverse Recovery Charge	Q _{RR}			5.4		nC

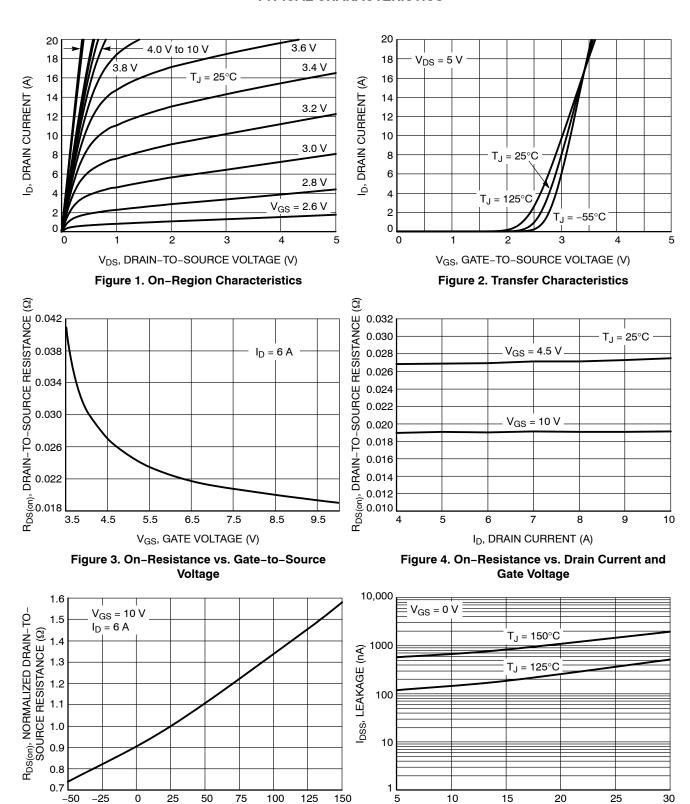
DEVICE ORDERING INFORMATION

Device	Package	Shipping [†]
NTLUS4930NTAG	UDFN6 (Pb-Free)	3000 / Tape & Reel
NTLUS4930NTBG	UDFN6 (Pb-Free)	3000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

^{5.} Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.
6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



T_J, JUNCTION TEMPERATURE (°C)

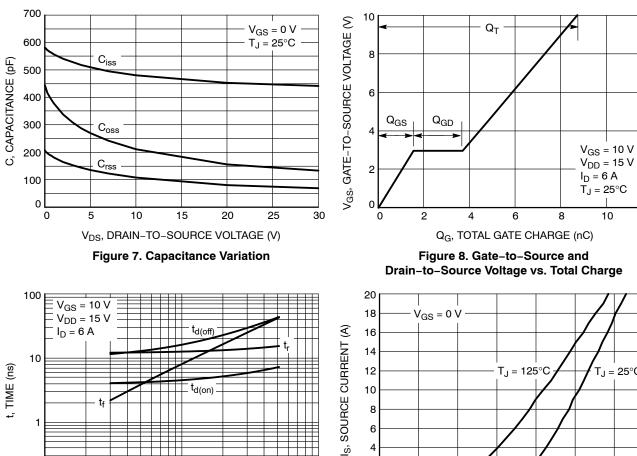
Figure 5. On-Resistance Variation with

Temperature

V_{DS}, DRAIN-TO-SOURCE VOLTAGE (V)

Figure 6. Drain-to-Source Leakage Current
vs. Voltage

TYPICAL CHARACTERISTICS



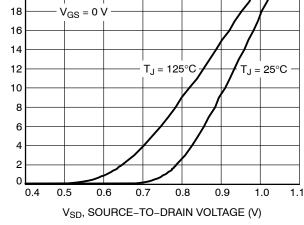
 R_G , GATE RESISTANCE (Ω) Figure 9. Resistive Switching Time Variation vs. Gate Resistance

10

 $t_{d(on)}$

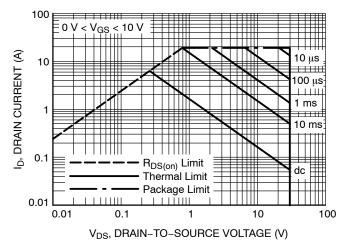
 t_{f}

0.1



12

Figure 10. Diode Forward Voltage vs. Current



100

Figure 11. Maximum Rated Forward Biased Safe Operating Area

TYPICAL CHARACTERISTICS

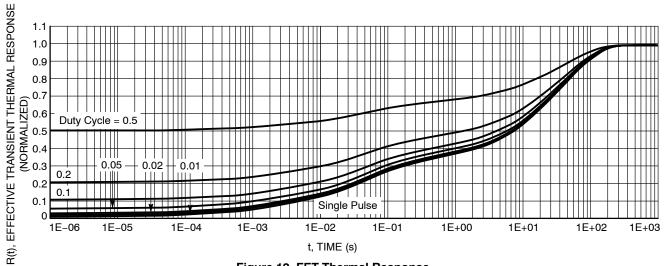


Figure 12. FET Thermal Response

DETAIL A

6X L

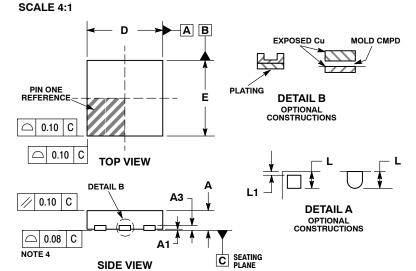
E2

J1

BOTTOM VIEW



DATE 04 FEB 2010



С 0.10

0.05 C NOTE 5

NOTE 3

Ф

0.10 С Α

С 0.05

Α



- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 2. CONTROLLING DIMENSION: MILLIMETERS.
- DIMENSION & APPLIES TO PLATED TERMINAL AND IS
 MEASURED BETWEEN 0.15 AND 0.30 mm FROM TERMINAL
 COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS
 THE TERMINALS. 3.
- 1. CENTER TERMINAL LEAD IS OPTIONAL CENTER TERMINAL IS CONNECTED TO TERMINAL LEAD # 4.
 2. LEADS 1, 2, 5 AND 6 ARE TIED TO THE FLAG.

	MILLIMETERS			
DIM	MIN	MAX		
Α	0.45 0.55			
A1	0.00	0.05		
A3	0.13	REF		
b	0.25	0.35		
b1	0.51	0.61		
D	2.00 BSC			
D2	1.00 1.20			
E	2.00 BSC			
E2	1.10	1.30		
е	0.65 BSC			
K	0.15 REF			
J	0.27 BSC			
J1	0.65 BSC			
L	0.20	0.30		
L1	1	0.10		
L2	0.20	0.30		

GENERIC MARKING DIAGRAM*



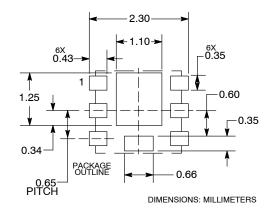
XX = Specific Device Code

M = Date Code

(Note: Microdot may be in either location)

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present.

RECOMMENDED **MOUNTING FOOTPRINT**



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